Search Notes					

Application No.	Applicant(s)	
10/619,601	MIZUNO ET AL.	
Examiner	Art Unit	
Ernest F. Karlsen	2829	

SEARCHED				
Class	Subclass	Date	Examiner	
324	765 719 766 768 769	9/17/2004	ε.?K.	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
324	765 769	9/17/2004	E.T.K.	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
substrate adj bias and threshold and MOS adj transistor\$ second same voltage same first same lower and IDDQ	9/17/2004	E.7K		
IDDQ same test same MOS adj transistor\$	9/17/2004	EZY		
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